

Emission Characteristics of Surface Microdischarge in Atmospheric-Pressure He/N₂ Mixture

Dong Li, Dingxin Liu, Qiuyue Nie, Dehui Xu, Qiaosong Li, and Michael G. Kong

Abstract—The surface microdischarge in atmospheric-pressure He/N₂ mixture is studied with an emphasis on its emission characteristics. It is found that the emission intensity and the pattern shape are strongly dependent on the N₂ concentration. The UV emission intensity increases by a factor of nine with the N₂ concentration up to 5%, after that it decreases moderately. Meanwhile, the luminous pattern expands and then shrinks from grounded mesh edge to the mesh center in the positive half-cycle, while it gradually brightens and then darkens in the central region of a mesh for the negative half-cycle, which is mainly attributed to the distribution of surface charge. In the case of [N₂] = 2%–5%, the UV-Vis emission intensity is stronger and the emission pattern is comparable to spatial homogenous, thus benefiting the light emission applications.

Index Terms—Atmospheric pressure, emission pattern, He/N₂ mixture, surface microdischarge.

THE SURFACE microdischarge (SMD) is capable of producing large-scale, macroscopic-homogeneous, and stable cold plasmas in a strong reactive feeding gas, thus facilitating various applications like plasma biomedicine [1]. Although much attention has been paid on the SMD in the last decade, the light emission characteristics have little been studied. This character is of importance due to: 1) the potential application of the SMD as a light source and 2) the UV band of light emission has various biological effects.

To this end, we present in this paper an experimental study on the emission characteristics of the SMD in atmospheric-pressure He/N₂ mixture. The discharge device is shown schematically in Fig. 1. It contains a plane active electrode, a grounded electrode made by woven wire mesh, a dielectric-slab sandwiched between the two electrodes, and a quartz box to shield the feeding gas from the open air. The grounded mesh has a hexagon shape with each side of 4-mm length and 0.5-mm thickness, and the plasma is generated in each mesh as long as a high voltage is applied. Pure helium (5 N) is fed into the discharge device with a flow rate of 5 L/min, and the concentration of nitrogen, varying from 0% to 15%,

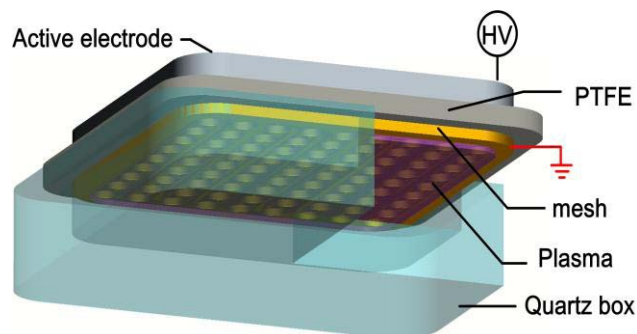


Fig. 1. Discharge device.

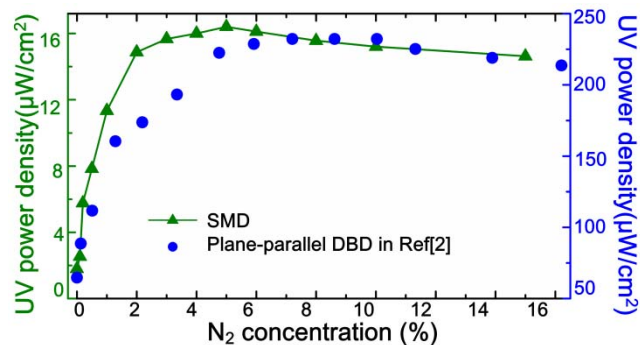


Fig. 2. Dependence of UV emission intensity on the N₂ concentration.

is controlled by a gas flow meter. A sinusoidal high voltage ($V_{pp} = 7$ kV, $f = 20$ kHz) is applied on the active electrode, and it is measured by an oscilloscope (Tektronix, DPO3000) with a high-voltage probe (Tektronix, P6015A). The emission pattern is observed by an intensified charge coupled device (ICCD) camera (Andor, DH334T), and the UV power density is obtained by a UV intensity meter (UDT Instrument, Model S471, 200–400 nm, 0.01 μ W/cm² for sensitivity).

The dependence of the UV emission intensity of SMD on the N₂ concentration is plotted in Fig. 2. The intensity increases sharply when [N₂] < 2%, and then continuous to grow but slightly until [N₂] = 5%, after that it decreases moderately. This trend is similar to that for a plane-parallel DBD, as presented in [2]. The UV emission band of He/N₂ discharge is mostly contributed by the molecular emission of N₂⁺(B²Σ_u⁺) and N₂(C²Π_u). As these two species are generated mainly by electron impact on N₂ molecules, the increase of N₂ density but corresponding decrease of electron density result in such trend of UV emission intensity [3].

The emission patterns of a full period are shown in Fig. 3(a)–(l). It can be observed that the luminous intensity

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D. Li, D. Liu, D. Xu, and Q. Li are with the Centre for Plasma Biomedicine, State Key Laboratory of Electrical Insulation and Power Equipment, Xi'an Jiaotong University, Xi'an 710049, China (e-mail: liudingxin@gmail.com).

Q. Nie is with the Department of Engineering Physics, Tsinghua University, Beijing 100084, China.

M. G. Kong is with the Frank Reidy Center for Bioelectrics, Old Dominion University, Norfolk, VA 23508 USA.

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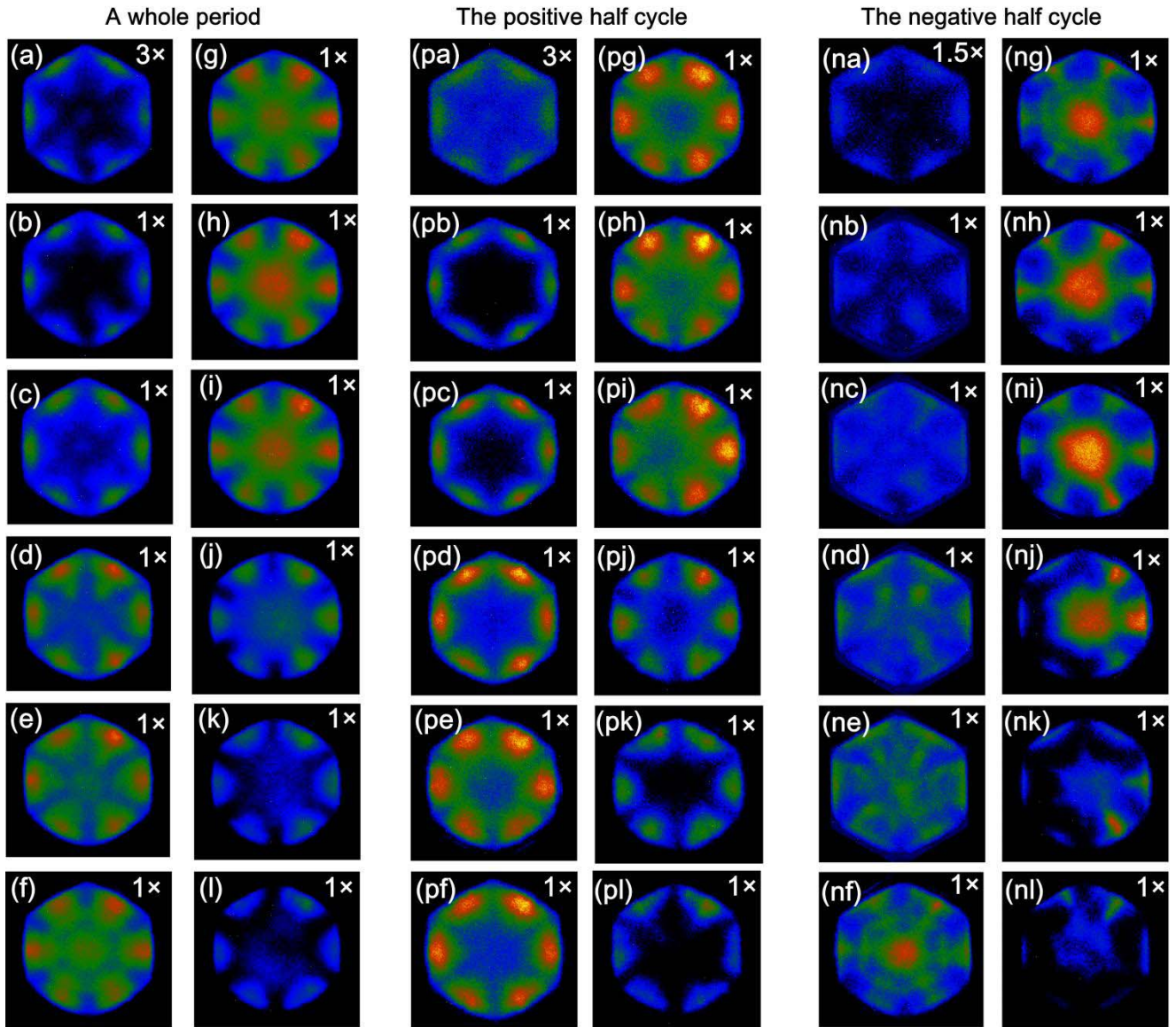


Fig. 3. Luminous patterns of the SMD in He/N₂ mixture for different N₂ concentrations. (a)–(l) Luminous patterns taken for a whole discharge cycle with N₂ concentrations of 0%, 0.1%, 0.2%, 0.5%, 1%, 2%, 3%, 4%, 5%, 6%, 8%, and 15%, respectively. (pa)–(pl) Luminous patterns taken for the positive half-cycle of applied voltage for the same N₂ concentrations as (a)–(l), and (na)–(nl) for the negative half-cycle. The emission intensity is artificially intensified when the image is too weak. For example, when marked with 3× it means that the emission intensity is multiplied by a factor of three.

($\lambda = 180\text{--}850$ nm for the ICCDs spectral scope) is most strong when $[N_2] = 2\%\text{--}5\%$, similar to that for the UV band. Moreover, in that case, the emission pattern is more homogeneous than the others. The full period images consist of the positive and negative half-cycle images, which are also taken by ICCD, as shown in Fig. 3(pa)–(pl) and (na)–(nl), respectively. It can be observed that the emission pattern expands and then shrinks from the mesh edge to the mesh center for the positive half-cycle, while it just gradually brightens and then darkens in the central region of a mesh for the negative half-cycle. This can be mainly attributed to the surface charge that deposited on the Polytetrafluoroethene surface, of which the existing region expands with higher density of nitrogen

metastables (Penning ionization) especially when $[N_2] = 2\%\text{--}5\%$ and hence can trigger a stronger reverse breakdown in the negative half-cycle.

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